

Application No.	Applicant(s)
10/612,017	KAMEYA, HISASHI
Examiner	Art Unit
Toan M Le	2863

-	SEARCHED			
Class	Subclass	Date	Examiner	
702	87	8/30/2004	TL	
73	862.331	8/27/2004	TL	
73	862.326	8/27/2004	TL	
341	112	9/17/2004	TL	
341	116	9/17/2004	TL	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
702	87	10/13/2004	TL		
341	112	10/13/2004	TL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Rotational Angular detection; Resolver; Gain; Offset	8/27/2004	TL		
Correcting Resolver Output; Offset; Gain; Average	8/27/2004	TL		
Resolver; Offset; Gain; Sine; Cosine	8/30/2004	TL		
Resolver; Error; Correction; Average; Differential, Max; Min	9/17/2004	TL		
East, Web, and NPL Search				